

# BTD21520x

## Dual-Channel Isolated Gate Driver

### 1.Features

- Isolation voltage up to 5000Vrms(SOW-14)@UL1577; 3000Vrms(SOP-16)@UL1577
- Secondary-side drive voltage range up to 33V
- 4-A peak source, 6-A peak sink at output
- Integrated disable function
- Integrated dead time setting
- Typical propagation delay 45ns
- Operating temperature -40~125°C

### 2.Applications

#### Industrial:

- Power distribution
- Motor drives
- Isolated switched-mode power supplies
- Lighting systems
- Plasma displays
- PV and industrial inverters

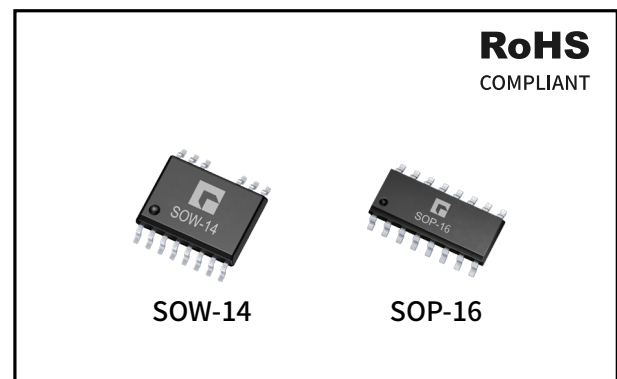
#### Automotive:

- On-board chargers
- Battery management systems
- Charging stations
- Traction inverters
- Hybrid electric vehicles
- Battery electric vehicles

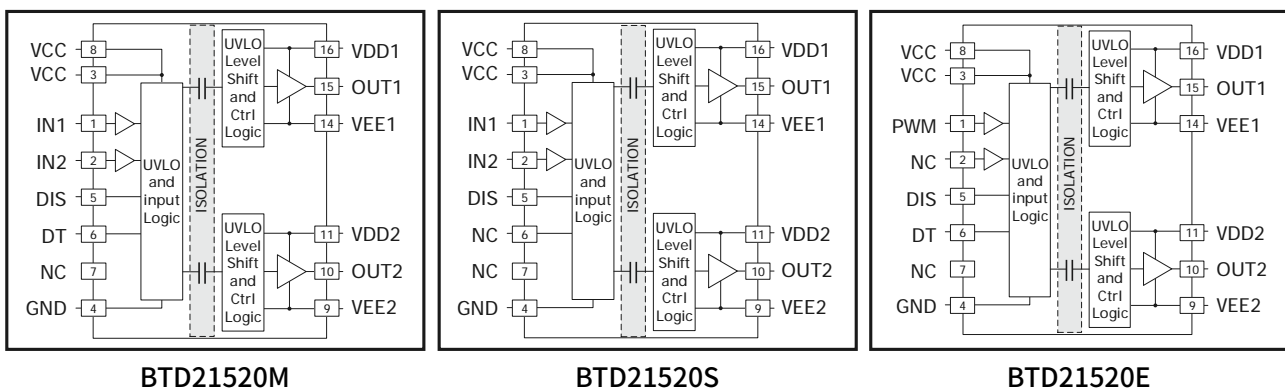
### 3.Description

BTD21520 is an isolated dual-channel gate driver with peak 4-A source current and peak 6-A sink current. It isolates primary-side from secondary-side by a 5k Vrms reinforced isolation barrier.

Internal functional isolation between the two secondary-side output channels allows a operating voltage of up to 1850 V<sub>DC</sub>. The driver can be configured as two low-side drivers, two high-side drivers, or a half-bridge driver with programmable dead time (DT). Certain models include disable (DIS) pin. When the DIS pin is set high, it shuts down both outputs simultaneously. When the DIS pin is left open or grounded, it allows the device to operate normally.



### 4.Functional Block Diagram



## INDEX

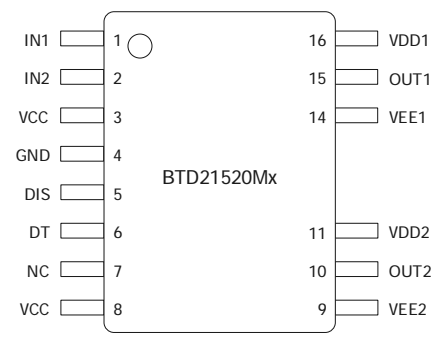
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## 5. Product Information

| Part No.     | Pin Configuration  | Secondary Side UVLO Threshold | Operating Temperature | Package | Package Material | Quantity      | Marking    |
|--------------|--|-------------------------------|-----------------------|---------|------------------|---------------|------------|
| BTD21520MAWR | Dual-channel non-inverting input, dead time configuration and disable function | 6V                            | -40-125°C             | SOW-14  | Tape & Reel      | 1500pcs /Reel | BTD21520MA |
| BTD21520MBWR |  | 8V                            |                       |         |                  |               | BTD21520MB |
| BTD21520SAWR | Dual-channel non-inverting input, disable function                             | 6V                            |                       |         |                  |               | BTD21520SA |
| BTD21520SBWR |  | 8V                            |                       |         |                  |               | BTD21520SB |
| BTD21520EAWR | Single PWM input, dead time configuration and disable function                 | 6V                            |                       |         |                  |               | BTD21520EA |
| BTD21520EBWR |  | 8V                            |                       |         |                  |               | BTD21520EB |
| BTD21520MAPR | Dual-channel non-inverting input, dead time configuration and disable function | 6V                            | -40-125°C             | SOP-16  | Tape & Reel      | 2500pcs /Reel | BTD21520MA |
| BTD21520MBPR |  | 8V                            |                       |         |                  |               | BTD21520MB |
| BTD21520SAPR | Dual-channel non-inverting input, disable function                             | 6V                            |                       |         |                  |               | BTD21520SA |
| BTD21520SBPR |  | 8V                            |                       |         |                  |               | BTD21520SB |
| BTD21520EAPR | Single PWM input, dead time configuration and disable function                 | 6V                            |                       |         |                  |               | BTD21520EA |
| BTD21520EBPR |  | 8V                            |                       |         |                  |               | BTD21520EB |

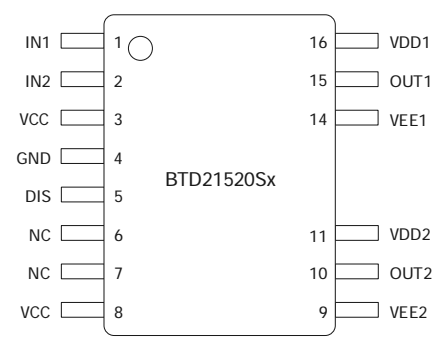
## 6.Pin Configuration and Functions

### 6.1 BTD21520Mx

| NO. | NAME | TYPE <sup>(1)</sup> | DESCRIPTION  | PACKAGE  |
|-----|------|---------------------|--|--|
| 1   | IN1  | I                   | Input signal for channel 1   |  |
| 2   | IN2  | I                   | Input signal for channel 2   |  |
| 3   | VCC  | P                   | Primary-side supply voltage  |  |
| 4   | GND  | G                   | Primary-side ground reference  |  |
| 5   | DIS  | I                   | Disables both driver outputs if asserted high, enables if set low or left open |  |
| 6   | DT   | I                   | Programmable dead time function  |  |
| 7   | NC   | -                   | No Internal connection   |  |
| 8   | VCC  | P                   | Primary-side supply voltage  |  |
| 9   | VEE2 | P                   | Ground for secondary-side driver 2   |  |
| 10  | OUT2 | O                   | Output of driver 2   |  |
| 11  | VDD2 | P                   | Secondary-side power for driver 2  |  |
| 14  | VEE1 | P                   | Ground for secondary-side driver 1   |  |
| 15  | OUT1 | O                   | Output of driver 1   |  |
| 16  | VDD1 | P                   | Secondary-side power for driver 1  |  |

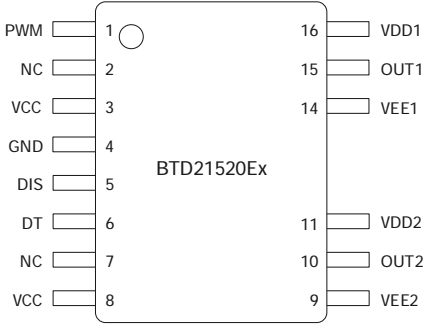
(1) P=Power, G=Ground, I=Input, O=Output

### 6.2 BTD21520Sx

| NO. | NAME | TYPE <sup>(1)</sup> | DESCRIPTION  | PACKAGE  |
|-----|------|---------------------|--|--|
| 1   | IN1  | I                   | Input signal for channel 1   |  |
| 2   | IN2  | I                   | Input signal for channel 2   |  |
| 3   | VCC  | P                   | Primary-side supply voltage  |  |
| 4   | GND  | G                   | Primary-side ground reference  |  |
| 5   | DIS  | I                   | Disables both driver outputs if asserted high, enables if set low or left open |  |
| 6   | NC   | -                   | No Internal connection   |  |
| 7   | NC   | -                   | No Internal connection   |  |
| 8   | VCC  | P                   | Primary-side supply voltage  |  |
| 9   | VEE2 | P                   | Ground for secondary-side driver 2   |  |
| 10  | OUT2 | O                   | Output of driver 2   |  |
| 11  | VDD2 | P                   | Secondary-side power for driver 2  |  |
| 14  | VEE1 | P                   | Ground for secondary-side driver 1   |  |
| 15  | OUT1 | O                   | Output of driver 1   |  |
| 16  | VDD1 | P                   | Secondary-side power for driver 1  |  |

(1) P=Power, G=Ground, I=Input, O=Output

### 6.3 BTD21520Ex

| NO. | NAME | TYPE <sup>(1)</sup> | DESCRIPTION  | PACKAGE  |
|-----|------|---------------------|--|--|
| 1   | PWM  | I                   | PWM control signal input   |  |
| 2   | NC   | -                   | No Internal connection   |  |
| 3   | VCC  | P                   | Primary-side supply voltage  |  |
| 4   | GND  | G                   | Primary-side ground reference  |  |
| 5   | DIS  | I                   | Disables both driver outputs if asserted high, enables if set low or left open |  |
| 6   | DT   | I                   | Programmable dead time function  |  |
| 7   | NC   | -                   | No Internal connection   |  |
| 8   | VCC  | P                   | Primary-side supply voltage  |  |
| 9   | VEE2 | P                   | Ground for secondary-side driver 2   |  |
| 10  | OUT2 | O                   | Output of driver 2   |  |
| 11  | VDD2 | P                   | Secondary-side power for driver 2  |  |
| 14  | VEE1 | P                   | Ground for secondary-side driver 1   |  |
| 15  | OUT1 | O                   | Output of driver 1   |  |
| 16  | VDD1 | P                   | Secondary-side power for driver 1  |  |

(1) P=Power, G=Ground, I=Input, O=Output

## 7. Specification Parameters

### 7.1 Absolute Maximum Ratings

| SYMBOL             | PARAMETER   | MIN       | MAX      | UNIT |
|--------------------|---|-----------|----------|------|
| VCC                | Input bias pin supply voltage (pin 3/pin 8)           | GND-0.3   | GND+6.5  | V    |
| VDDx               | Driver bias supply (to VEEEx)                         | VEEEx-0.3 | VEEEx+35 |      |
| V <sub>o</sub>     | Output signal voltage                                 | VEEEx-0.3 | VDDx+0.3 |      |
| V <sub>IN</sub>    | Input signal voltage (INx, PWM, DIS, DT to GND)       | GND-0.3   | VCC+0.3  |      |
| -                  | Channel to channel voltage                            | -         | 1850     |      |
| T <sub>J</sub>     | Junction Temperature                                  | -40       | 150      | °C   |
| T <sub>S</sub>     | Storage Temperature                                   | -65       | 150      |      |
| T <sub>L</sub>     | Soldering Temperature (10s)                           | -         | 300      |      |
| V <sub>(ESD)</sub> | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001    | ±4000     |          | V    |
|                    | Charge-device model (CDM), per ANSI/ESDA/JEDEC JS-002 | ±1500     |          |      |
| -                  | Input signal voltage(IN1,IN2 Transient for 50ns)      | -5        | VCC+0.3  |      |

Note: The above are stress levels only. Devices are not recommended to operate under these or any other conditions beyond these values. Prolonged operation under the absolute maximum rating may affect the reliability of the device, and in severe cases it may cause permanent damage to the devices.

### 7.2 Thermal Information

| SYMBOL                | DESCRIPTION                                  | SOW-14 | SOP-16 | UNIT  |
|-----------------------|--|--------|--------|-------|
| R <sub>θJA</sub>      | Junction-to-ambient thermal resistance       | 52.82  | TBD    | °C /W |
| R <sub>θJC(top)</sub> | Junction-to-case (top) thermal resistance    | 16.19  | TBD    |       |
| R <sub>θJB</sub>      | Junction-to-board thermal resistance         | 40.18  | TBD    |       |
| ψ <sub>JT</sub>       | Junction-to-top characterization parameter   | 26.64  | TBD    |       |
| ψ <sub>JB</sub>       | Junction-to-board characterization parameter | 44.75  | TBD    |       |

### 7.3 Power Ratings

| SYMBOL          | PARAMETER  | TEST CONDITIONS  | SOW-14 | SOP-16 | UNIT |
|-----------------|--|--|--------|--------|------|
| P <sub>D</sub>  | Power dissipation by BTD21520x                     | VCC=5V, VDD1/2=12V, IN1/2=3.3V, 3MHz, 50% duty cycle square wave, 1nF load | 1.14   | TBD    | W    |
| P <sub>D1</sub> | Power dissipation by each driver side of BTD21520x |  | 0.56   | TBD    |      |
| P <sub>D2</sub> |  |  | 0.56   | TBD    |      |
| P <sub>DI</sub> | Power dissipation by transmitter side of BTD21520x |  | 0.02   | TBD    |      |

### 7.4 Recommended Operation Conditions

| SYMBOL          | PARAMETER                         | TEST CONDITIONS | MIN | MAX | UNIT |
|-----------------|-----------------------------------|-----------------|-----|-----|------|
| VCC             | Input supply voltage              | -               | 3   | 5   | V    |
| VDDx            | Driver output bias supply         | -               | -   | 33  |      |
| V <sub>IN</sub> | Input voltage range IN1, IN2, PWM | -               | 0   | VCC |      |
| T <sub>A</sub>  | Operating ambient temperature     | -               | -40 | 125 | °C   |

## 7.5 Safety-Limiting Values

| SYMBOL         | PARAMETER                         | TEST CONDITIONS   | SIDE       | MIN                | MAX | UNIT |    |
|----------------|-----------------------------------|---|------------|--------------------|-----|------|----|
| I <sub>s</sub> | Safety output supply current      | T <sub>A</sub> =25°C, T <sub>J</sub> =150°C             | VDD1/2=12V | CHANNEL1, CHANNEL2 | -   | 97   | mA |
|                |                                   |   | VDD1/2=25V | CHANNEL1, CHANNEL2 | -   | 47   |    |
| P <sub>s</sub> | Safety supply power               | VDD1/2=25V, T <sub>A</sub> =25°C, T <sub>J</sub> =150°C | INPUT      |                    | -   | 20   | mW |
|                |                                   |   | CHANNEL1   |                    | -   | 1170 |    |
|                |                                   |   | CHANNEL2   |                    | -   | 1170 |    |
|                |                                   |   | TOTAL      |                    | -   | 2360 |    |
| T <sub>s</sub> | Safety temperature <sup>(1)</sup> |   |            | -                  | 150 | °C   |    |

(1) The maximum safety temperature, T<sub>s</sub>, has the same value as the maximum junction temperature, T<sub>J</sub>, specified for the device.

The I<sub>s</sub> and P<sub>s</sub> parameters represent the safety current and safety power respectively. The maximum limits of I<sub>s</sub> and P<sub>s</sub> should not be exceeded. These limits vary with the ambient temperature, T<sub>A</sub>.

## 7.6 Electrical Characteristics

T<sub>A</sub>=-40~125°C, VCC=3.3V or 5V, VDD1=VDD2=12V, C<sub>L</sub><sup>(1)</sup>=100pF. Output pin: current towards outside of the chip is positive direction; Input pin: current towards inside of the chip is positive direction.

| SYMBOL                                       | PARAMETER   | TEST CONDITIONS  | MIN       | TYP | MAX | UNIT |   |
|--|---|--|-----------|-----|-----|------|---|
| <b>Input Characteristics</b>                 |   |  |           |     |     |      |   |
| V <sub>IH</sub>                              | Input logic 1 (INx, DIS, PWM)                     | VCC=5V   | 2.1       | 2.4 | 2.7 | V    |   |
| V <sub>IL</sub>                              | Input logic 0 (INx, DIS, PWM)                     | -  | 1.1       | 1.4 | 1.7 |      |   |
| V <sub>IN,HYS</sub>                          | Input Hysteresis                                  | -  | -         | 1   | -   |      |   |
| I <sub>VCC</sub>                             | VCC quiescent current                             | -  | -         | 1.5 | 2   | mA   |   |
| I <sub>VDDx</sub>                            | VDDx quiescent current                            | -  | -         | 1   | 1.8 |      |   |
| <b>Primary side UVLO Thresholds (VCC)</b>    |   |  |           |     |     |      |   |
| V <sub>ON1</sub>                             | Rising threshold                                  | -  | -         | 2.6 | -   | V    |   |
| V <sub>OFF1</sub>                            | Falling threshold                                 | -  | -         | 2.5 | -   |      |   |
| V <sub>UV,HYS1</sub>                         | Threshold hysteresis                              | -  | -         | 0.1 | -   |      |   |
| <b>Secondary side UVLO Thresholds (VDDx)</b> |   |  |           |     |     |      |   |
| V <sub>ON2</sub>                             | Rising threshold                                  | BTD21520xAx  | -         | 6   | 6.3 | V    |   |
| V <sub>OFF2</sub>                            | Falling threshold                                 |  | -         | 5.4 | 5.7 |      | - |
| V <sub>UV,HYS2</sub>                         | Threshold hysteresis                              |  | -         | -   | 0.3 |      | - |
| V <sub>ON2</sub>                             | Rising threshold                                  | BTD21520xBx  | -         | 8.7 | 9.2 |      |   |
| V <sub>OFF2</sub>                            | Falling threshold                                 |  | -         | 7.8 | 8.2 |      | - |
| V <sub>UV,HYS2</sub>                         | Threshold hysteresis                              |  | -         | -   | 0.5 |      | - |
| <b>Output Characteristics</b>                |   |  |           |     |     |      |   |
| I <sub>OH</sub>                              | Peak output source current                        | C <sub>VDD</sub> =10μF,<br>C <sub>LOAD</sub> =0.18μF, f=1kHz | -         | 4   | -   | A    |   |
| I <sub>OL</sub>                              | Peak output sink current                          |  | -         | 6   | -   |      |   |
| I <sub>VTS</sub>                             | OUTx pin reverse sinking tolerance                |  | 1us pulse | -   | 5   |      | - |
| VDD-V <sub>O</sub>                           | Output voltage at high state                      | I <sub>OUT</sub> =10mA                                       | -         | 60  | -   | mV   |   |
| V <sub>O</sub> -V <sub>EE</sub>              | Output voltage at low state                       | I <sub>OUT</sub> =-10mA                                      | -         | 5.5 | -   |      |   |
| R <sub>OHx</sub>                             | Output resistance at high state                   | I <sub>OUT</sub> =10mA, T <sub>A</sub> =25°C                 | -         | 6.5 | -   | Ω    |   |
| R <sub>OLx</sub>                             | Output resistance at low state                    | I <sub>OUT</sub> =-10mA, T <sub>A</sub> =25°C                | -         | 0.5 | -   |      |   |
| <b>Active Pull-Down Function</b>             |   |  |           |     |     |      |   |
| V <sub>OUTSD</sub>                           | Active pull-down voltage from OUTx pin to VEE pin | I <sub>OUT</sub> =-1A, VDDx=floating                         | -         | 2.5 | -   | V    |   |

(Continued)

| Switching Parameters      |  |  |  |     |     |            |
|---------------------------|--|--|--|-----|-----|------------|
| $t_{PLH}$                 | Turn-on delay (INx to OUTx)                      | -  | -  | 40  | -   | ns         |
| $t_{PHL}$                 | Turn-off delay (INx to OUTx)                     | -  | -  | 45  | -   |            |
| $t_r$                     | Output rise time                                 | $C_L=1nF$ , 20% to 80%   | -  | 10  | 26  | ns         |
| $t_f$                     | Output fall time                                 | $C_L=1nF$ , 90% to 10%   | -  | 10  | 26  |            |
| $t_{PVD}$                 | Pulse width distortion $ t_{PHL}-t_{PLH} $       | -  | -  | -   | 12  |            |
| $t_{DM}$                  | Propagation delays matching between VOUT1, VOUT2 | $f=100kHz$ , $IN1=IN2$   | -  | -   | 5   |            |
| DT                        | Dead time  | DT pull up to VCC  | Two output channels are completely independent |     |     | -          |
|                           |  | DT pin open (not recommended)  | -  | 8   | 15  | ns         |
|                           |  | $R_{DT}=20k\Omega$   | 160  | 200 | 250 |            |
| $t_{sk}$                  | Delay variation between samples                  | Under the same supply voltage, operating temperature, input and load conditions, $C_L=100pF$ | -  | 1   | 25  | ns         |
| $t_{VCC+ \text{ to OUT}}$ | Undervoltage lockout recovery time               | IN1, IN2 connected to VCC  | -  | 40  | -   | $\mu s$    |
| $t_{VDD+ \text{ to OUT}}$ |  |  | -  | 50  | -   |            |
| CMTI                      | Common-mode transient immunity                   | INx tied to GND or VCC, $V_{CM}=1500V$   | 100  | -   | -   | $kV/\mu s$ |

 (1)  $C_L$ : Load capacitance from output pin OUTx to VEEs.



## 7.7 SAFETY PARAMETERS

### 7.7.1 WIDE-BODY PACKAGE (SOW-14)

| Symbol             | PARAMETER                                 | TEST CONDITIONS  | MIN       | TYP | MAX | UNIT          |
|--------------------|---|--|-----------|-----|-----|---------------|
| CLR                | External clearance                        | Shortest pin-to-pin distance through air   | 8.5       | -   | -   | mm            |
| CPG                | External creepage                         | Shortest pin-to-pin distance across the package surface  | 8.5       | -   | -   |               |
| DTI                | Distance through insulation               | Minimum internal gap (internal clearance) of the double insulation ( $2 \times 8.5 \mu\text{m}$ )  | 17        | -   | -   | $\mu\text{m}$ |
| CTI                | Comparative tracking index                | DIN EN 60112   | 600       | -   | -   | V             |
| -                  | Overvoltage category                      | Voltage rating $\leq 600\text{Vrms}$   | I-III     | -   | -   | -             |
|                    |   | Voltage rating $\leq 1000\text{Vrms}$  | I-II      | -   | -   |               |
| <b>VDE 0884-11</b> |   |  |           |     |     |               |
| $V_{IORM}$         | Maximum repetitive peak isolation voltage | AC voltage (bipolar)   | 2121      | -   | -   | $V_{PK}$      |
| $V_{IOWM}$         | Maximum working isolation voltage         | AC voltage (sine wave); time dependent dielectric breakdown  | 1500      | -   | -   | Vrms          |
| $V_{IOTM}$         | Maximum transient isolation voltage       | $V_{TEST}=V_{IOTM}$ , 60s (qualification),<br>$V_{TEST}=1.2V_{IOTM}$ , 1s (production)   | 7000      | -   | -   | $V_{PK}$      |
| $V_{IOSM}$         | Maximum surge isolation voltage           | IEC 62368-1, 1.2/50 $\mu\text{s}$ waveform,<br>$V_{TEST}=1.6V_{IOSM}$ (qualification)  | 8000      | -   | -   |               |
| $Q_{pd}$           | Apparent charge                           | Method a, After Input/Output safety test subgroup 2/3. $V_{INI}=V_{IOTM}$ , 60s, $V_{pd}=1.2V_{IORM}$ , 10s                                      | -         | -   | 5   | pC            |
|                    |   | Method a, After environmental tests subgroup 1. $V_{INI}=V_{IOTM}$ , 60s, $V_{pd}=1.6V_{IORM}$ , 10s   | -         | -   | 5   |               |
|                    |   | Method b1; At routine test (100% production) and preconditioning (type test) $V_{INI}=1.2V_{IOTM}$ , 1s, $V_{pd}=1.875V_{IORM}$ , 1s             | -         | -   | 5   |               |
| $C_{io}$           | Barrier capacitance, input to output      | $V_{IO}=0.4V_{peak}$ , $f=1\text{MHz}$ , sine wave   | -         | 1.2 | -   | pF            |
| $R_{io}$           | Isolation resistance, input to output     | Test voltage of 500V, $T_A=25^\circ\text{C}$   | $10^{12}$ | -   | -   | $\Omega$      |
|                    |   | Test voltage of 500V, $100^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$  | $10^{11}$ | -   | -   |               |
|                    |   | Test voltage of 500V, $T_S=150^\circ\text{C}$  | $10^9$    | -   | -   |               |
| -                  | Pollution degree                          | -  | -         | 2   | -   | -             |
| <b>UL1577</b>      |   |  |           |     |     |               |
| $V_{ISO}$          | Withstand isolation voltage               | $V_{TEST}=V_{ISO}=5000\text{Vrms}$ , $t=60$ sec(qualification),<br>$V_{TEST}=1.2 \times V_{ISO}=6000\text{Vrms}$ ,<br>$t=1$ sec(100% production) | 5000      | -   | -   | Vrms          |

### 7.7.2 Safety-Related Certifications (SOW-14)

| UL   | VDE   | CQC   |
|--|---|---|
| Recognized under UL 1577 Component Recognition Program | Plan to certify according to DIN VDE V0884-11:2017-01 and DIN EN 61010-1  | Plan to certify according to GB 4943.1-2022                           |
| Single protection, 5000 $V_{RMS}$                      | Reinforced Insulation<br>Maximum Transient Isolation Overvoltage, 7000 $V_{PK}$ ;<br>Maximum Repetitive Peak Isolation Voltage, 2121 $V_{PK}$ ;<br>Maximum Surge Isolation Voltage, 8000 $V_{PK}$ | Reinforced Insulation,<br>Altitude $\leq 5000$ m,<br>Tropical Climate |
| File Number: E537161                                   | Certification planned   | Certification planned   |

## 8. Parameter Testing

### 8.1 Propagation Delay and Pulse Width Distortion

The figure below shows the characterization of pulse width distortion ( $t_{PWD}$ ) and delay matching ( $t_{DM}$ ). During the test, both inputs are in phase, the dead time function is disabled by shorting the DT Pin to VCC.

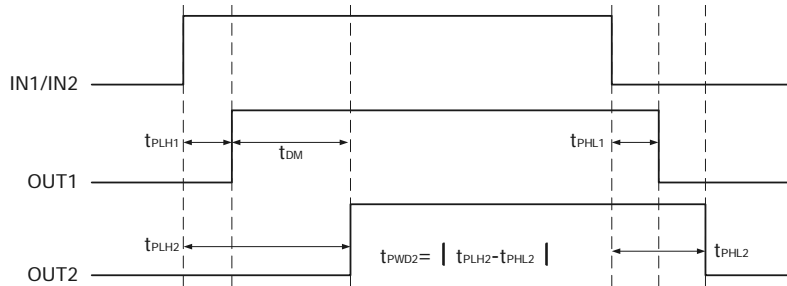


Figure 1. Dead Time Disabled, IN1 and IN2 with synchronized signal

### 8.2 Rise Time and Fall Time



Figure 2. Definition of Rise Time and Fall Time

### 8.3 Input and Disable Response Time

When the DIS pin is connected to the controller at a certain distance, it is recommended to configure a bypass capacitor of about 1nF with low stray inductance close to the DIS pin.

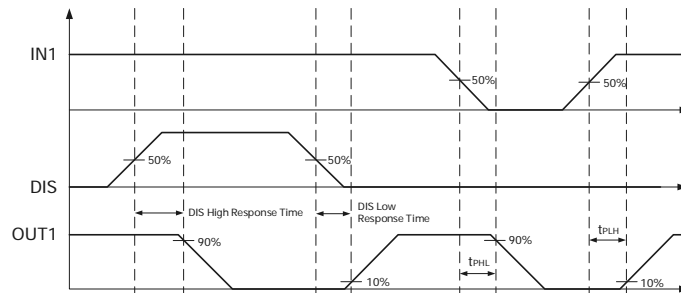


Figure 3. Disable Pin Timing

### 8.4 Programmable Dead Time

DT pin left open or connected to GND via resistor  $R_{DT}$  sets dead time between two channels.

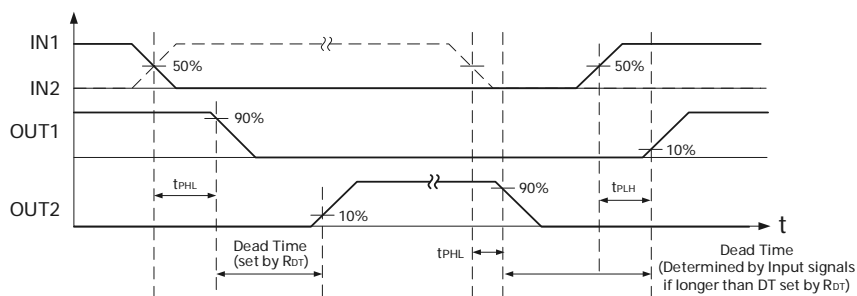


Figure 4. Dead-Time Switching Parameters

### 8.5 CMTI Testing

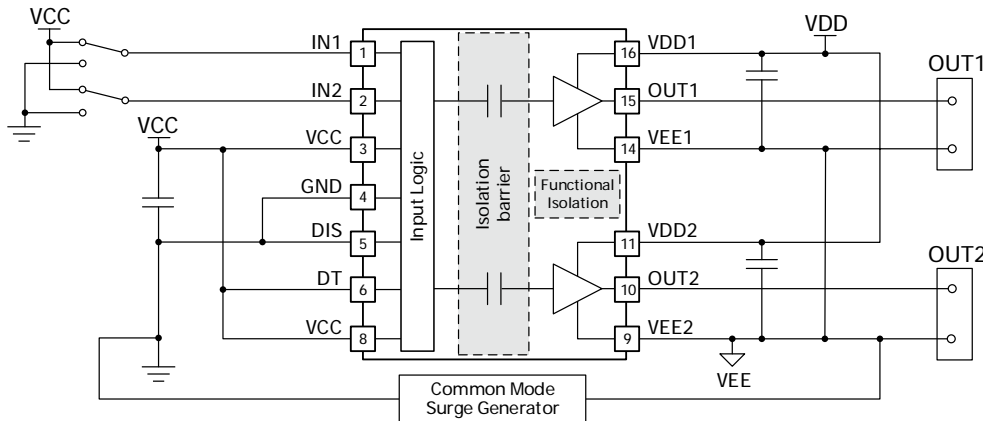


Figure 5. Simplified CMTI Test Setup

### 8.6 UVLO Delay During IC Power-On

At the process of device power-on, there is a time delay from the start of the supply voltage rise to the UVLO recovery threshold, and then to the device output response, as shown in the figures below.  $t_{VCC+ \text{ to } OUT}$  is primary side power-on UVLO delay (typical value 40 $\mu$ s), and  $t_{VDD+ \text{ to } OUT}$  is secondary side power-on UVLO delay (typical value 50 $\mu$ s). It is suggested that after powering on the driver IC, adequate time margin is reserved before sending PWM signal to IC.

If IN1 or IN2 is already at high level before VCC or VDDx reaches the recovery threshold, after  $t_{VCC+ \text{ to } OUT}$  or  $t_{VDD+ \text{ to } OUT}$  counting from the time point when VCC or VDDx reaches the recovery threshold, the corresponding output will jump to a high level. However, when the VCC or VDDx voltage drops to the UVLO lockout threshold, the output will be completely blocked within 1 $\mu$ s. This asymmetric design is to ensure safe operation of a VCC or VDDx in the event of a power failure.

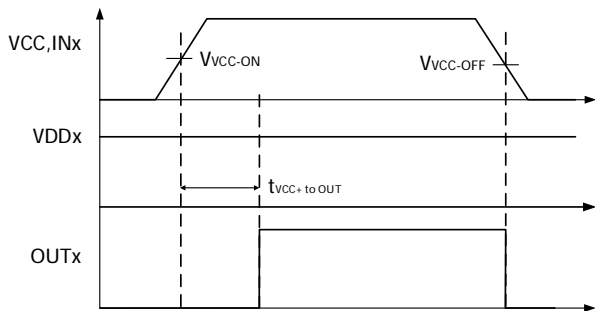


Figure 6. UVLO delay when the VCC is powered on

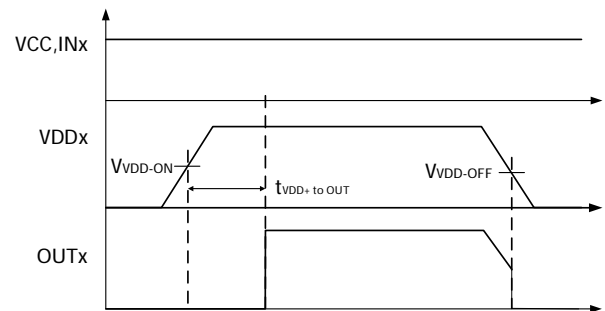


Figure 7. UVLO delay when the VDDx is powered on

### 8.7 Typical Characteristics

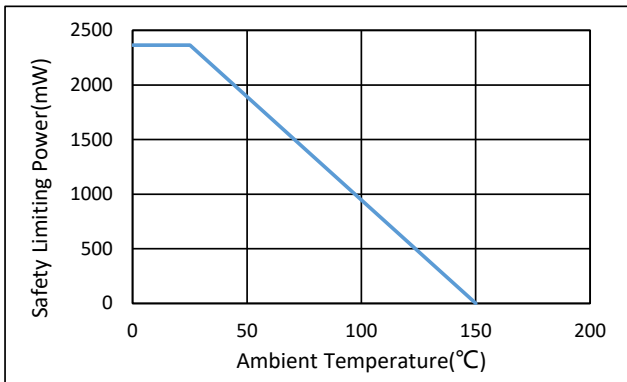


Figure 8. Thermal derating curve for safety-related limiting power

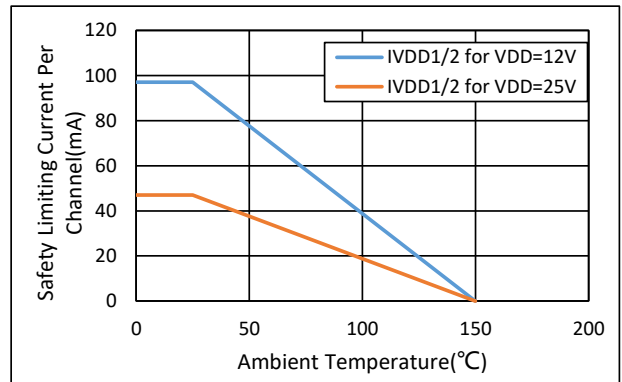


Figure 9. Thermal derating curve for safety-related limiting current (current in each channel with both channels running simultaneously)

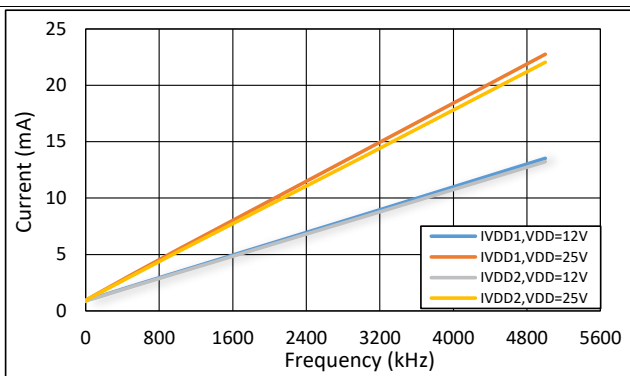


Figure 10. Per channel current consumption vs frequency (No Load, VDDx = 12 V or 25 V)

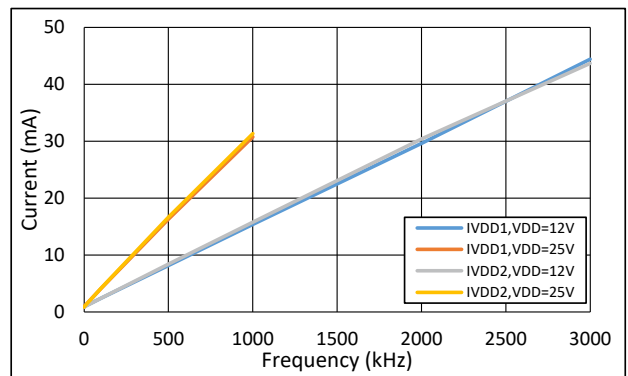


Figure 11. Per channel current consumption vs frequency (1-nF Load, VDDx = 12 V or 25 V)

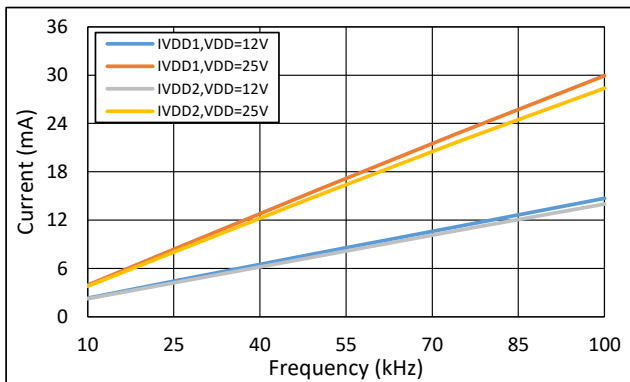


Figure 12. Per channel current consumption vs frequency (10-nF Load, VDDx = 12 V or 25 V)

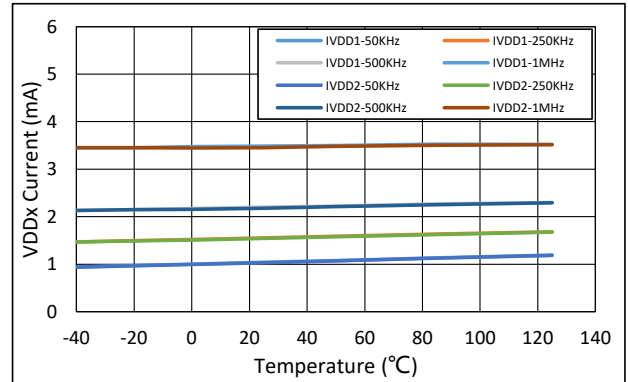


Figure 13. Per channel supply current Vs. temperature (No load, Different switching frequencies)

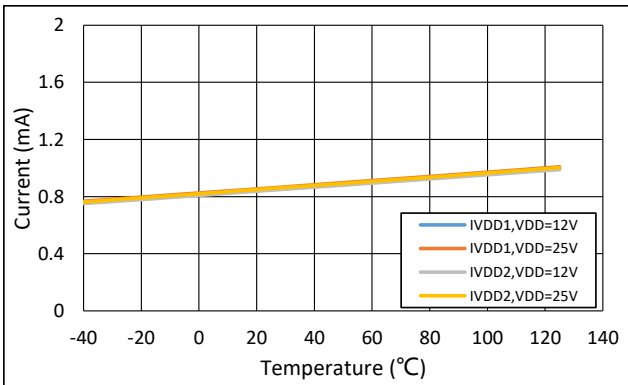


Figure 14. Secondary side per channel quiescent supply current vs temperature (No load, input low)

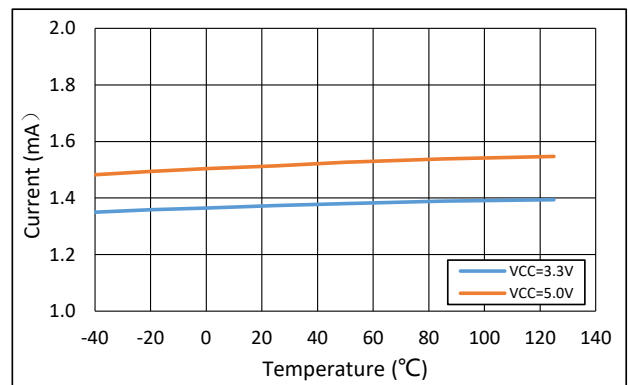


Figure 15. Primary side quiescent supply current vs temperature (No load, input low)

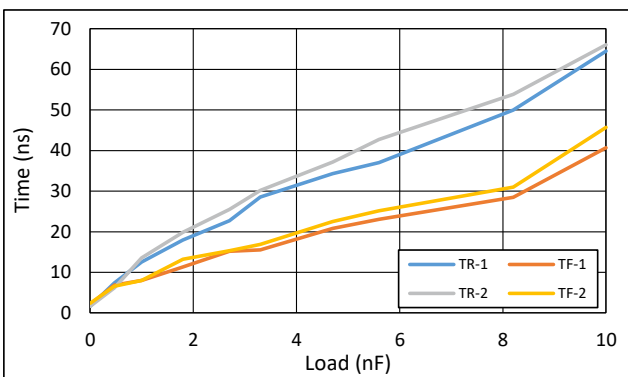


Figure 16. Rising and falling times vs load (VDDx = 12 V)

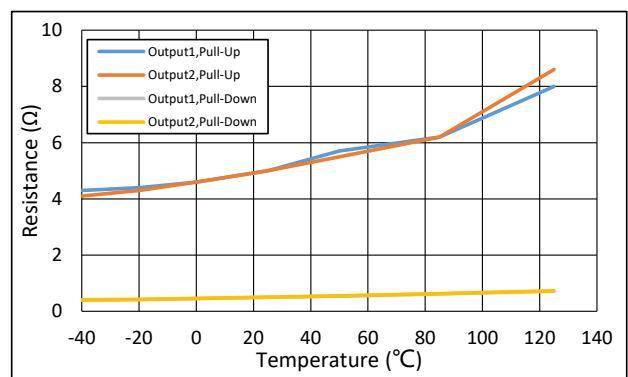


Figure 17. Output resistance vs temperature

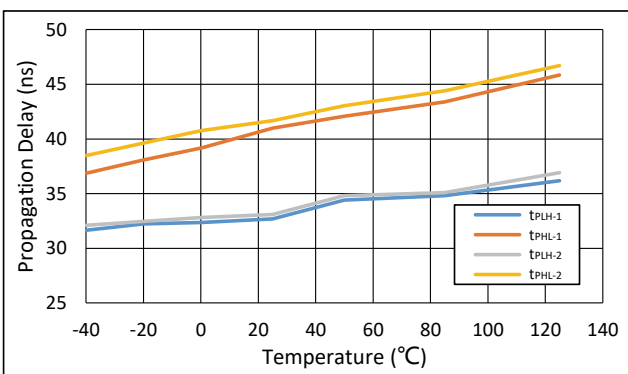


Figure 18. Propagation delay vs temperature

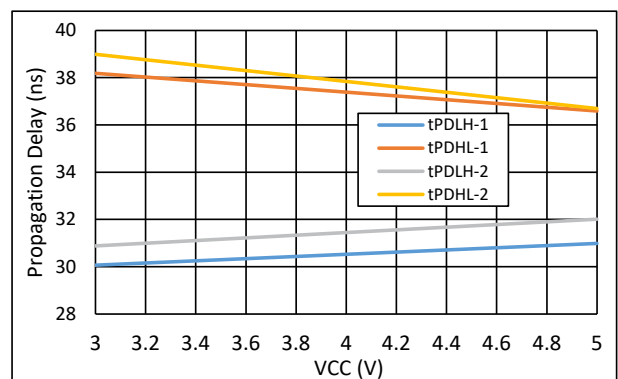


Figure 19. Propagation delay vs VCC

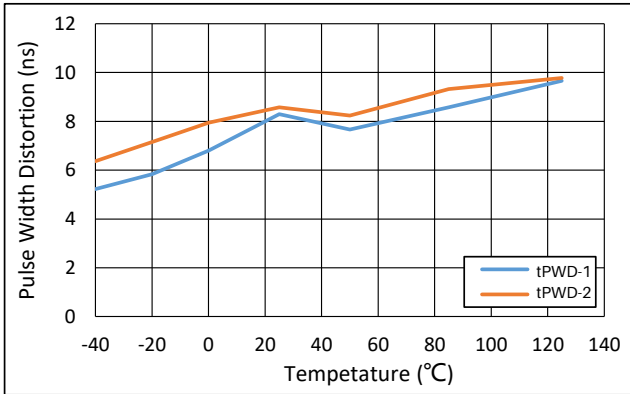


Figure 20. Pulse width distortion vs temperature

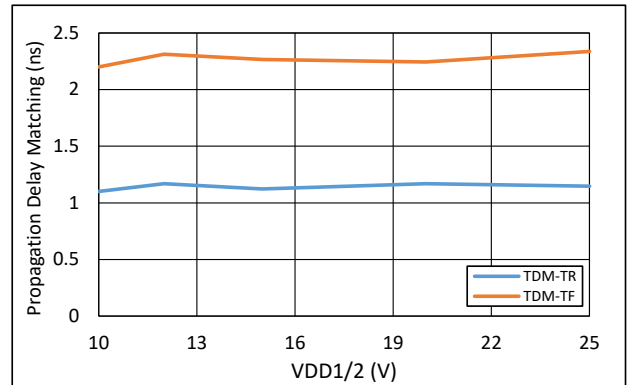


Figure 21. Propagation delay matching vs VDDx

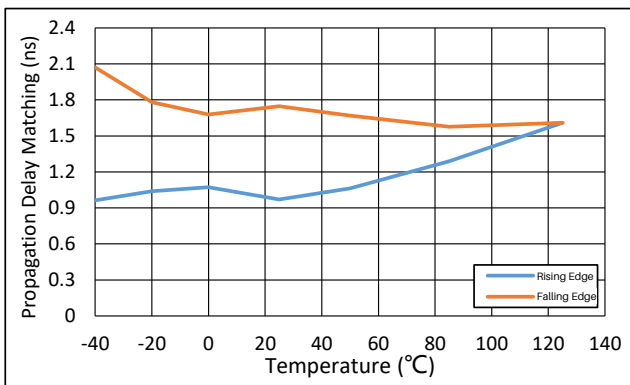


Figure 22. Propagation delay matching vs temperature

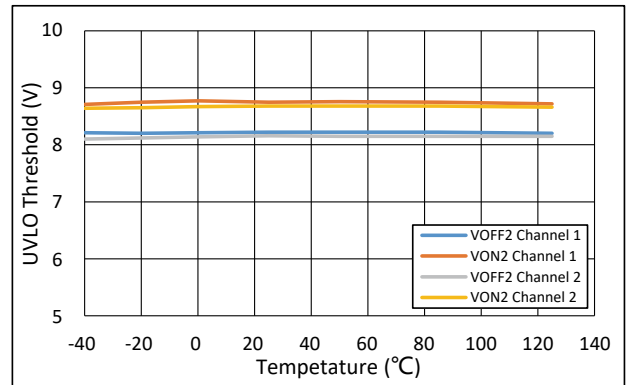


Figure 23. VDDx 8-V UVLO hysteresis vs temperature

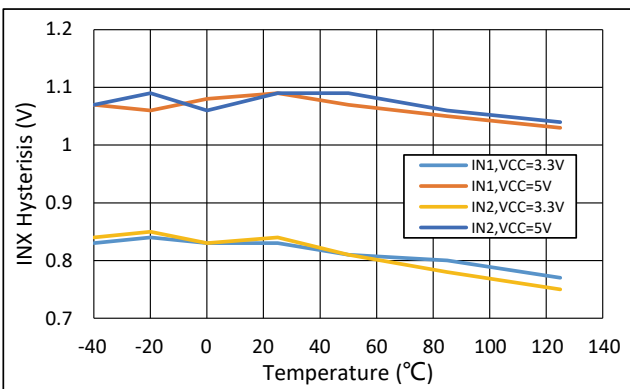


Figure 24. INx hysteresis vs temperature

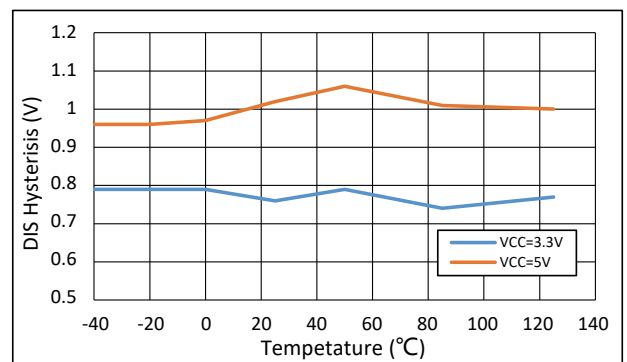


Figure 25. DIS hysteresis vs temperature

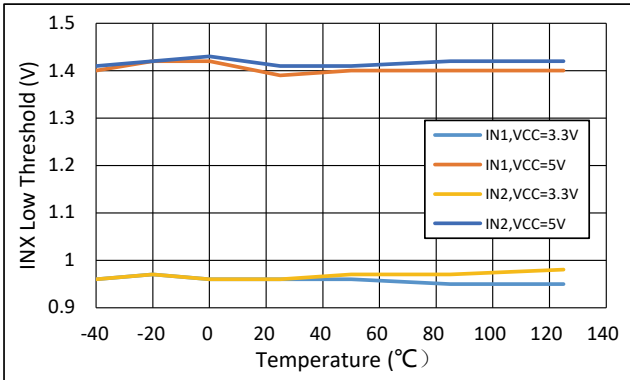


Figure 26. INx low threshold vs temperature

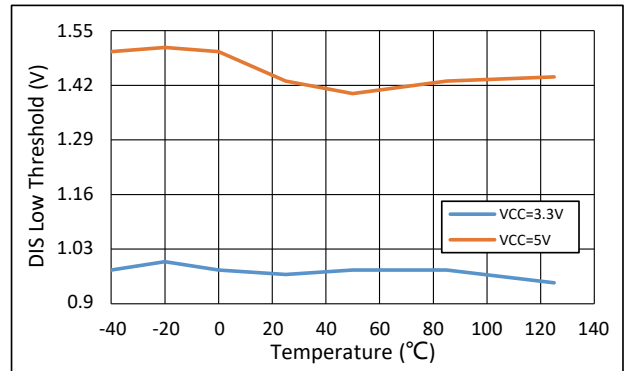


Figure 27. DIS low threshold vs temperature

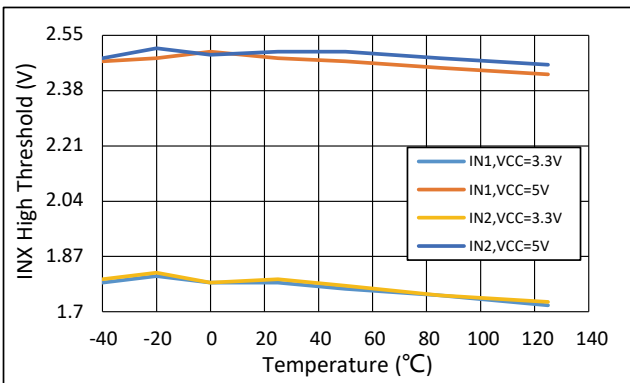


Figure 28. INx high threshold vs temperature

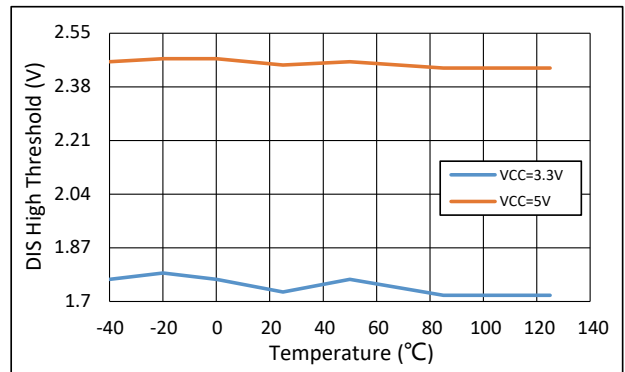


Figure 29. DIS high threshold vs temperature

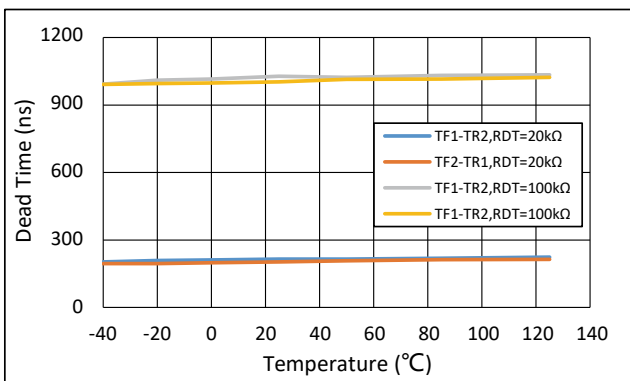


Figure 30. Dead time vs temperature

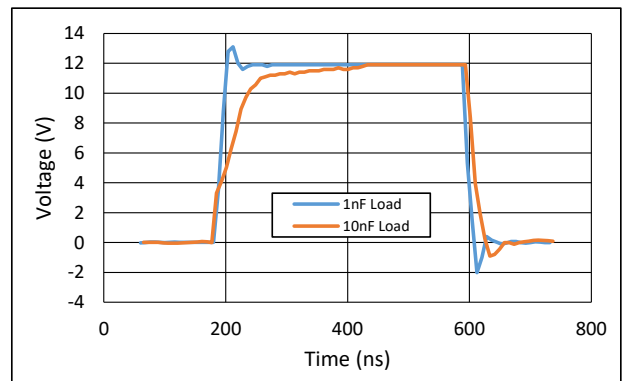


Figure 31. Typical output waveforms

## 9. Function Description

### 9.1 Block Diagram

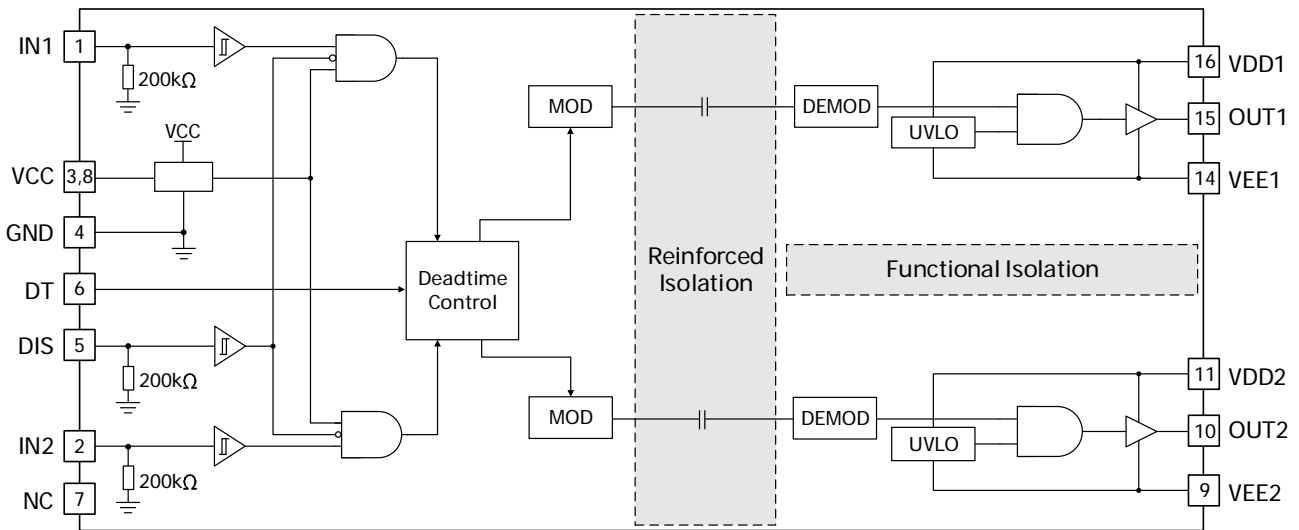


Figure 32. Functional Block Diagram (BTD21520Mx)

### 9.2 Input and Output Logic Table

When VCC and VDD are powered on, the relevant input and output logic information is as follows:

BTD21520M

| INPUT     |           | DIS            | OUTPUT |      | DESCRIPTION   |
|-----------|-----------|----------------|--------|------|---|
| IN1       | IN2       |                | OUT1   | OUT2 |   |
| L         | L         | L or left open | L      | L    | If dead time function is used, output switching occurs after the dead time ended. See Programmable Dead Time (DT) pin |
| L         | H         | L or left open | L      | H    |   |
| H         | L         | L or left open | H      | L    | DT is left open or programmed with $R_{DT}$   |
| H         | H         | L or left open | H      | H    |   |
| Left open | Left open | L or left open | L      | L    | -   |
| X         | X         | H              | L      | L    | -   |

BTD21520S

| INPUT     |           | DIS            | OUTPUT |      | DESCRIPTION  |
|-----------|-----------|----------------|--------|------|--|
| IN1       | IN2       |                | OUT1   | OUT2 |  |
| L         | L         | L or left open | L      | L    | No internal dead time setting, two output channels are independent |
| L         | H         | L or left open | L      | H    |  |
| H         | L         | L or left open | H      | L    |  |
| H         | H         | L or left open | H      | H    |  |
| Left open | Left open | L or left open | L      | L    | -  |
| X         | X         | H              | L      | L    | -  |

BTD21520E

| PWM INPUT   | DIS | OUTPUT |      | DESCRIPTION  |
|-------------|-----|--------|------|--|
|             |     | OUT1   | OUT2 |  |
| H           | L   | H      | L    | If dead time function is used, output jumps after dead time ended. See Programmable Dead Time (DT) pin |
| L/Left open | L   | L      | H    |  |
| X           | H   | L      | L    | Device disabled  |

(1) "X" means L, H or left open.



### 9.3 Input Stage Characteristics

With input pins and secondary side completely isolated, BTD21520 is designed to be compatible with CMOS levels, and supports 3.3V and 5V level input, making the chip easy to accept control of multiple logic levels. Inputs with Schmitt stage for improved anti-interference performance. INx, PWM, and DIS have a built-in 200kΩ resistor pulled down to the ground, ensuring that the output of the device is low when the input is left open. However, in order to ensure the initial power-on state of the device, it is recommended to add an appropriate pull-up or pull-down resistor to the input.

### 9.4 Output Booster Characteristic

The BTD21520 has a rail-to-rail booster stage output. The pull-up structure of the output stage consists of a P-channel MOSFET and an N-channel MOSFET connected in parallel. At turn-on, N-channel MOSFET provides high current driving capability. P-channel MOSFET provides a small steady-state conduction voltage drop. The PMOS on-resistance ( $R_{OH}$ ) is 6.5Ω, and the NMOS on-resistance ( $R_{NMOS\_ON}$ ) is 0.5Ω.

The pull-down structure is implemented using an N-channel MOSFET. A 1MΩ resistor is connected in parallel between the drain and gate of the MOSFET to effectively clamp the gate voltage of the power device in the event of a loss of power to prevent the occurrence of partial turn-on. However, in order to ensure reliable shutdown of the power device, it is recommended that appropriate pull-down resistor be added to the gate.

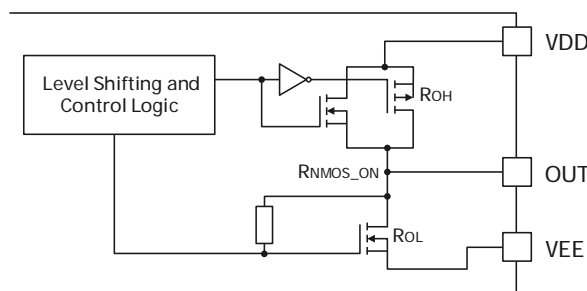


Figure 33. Output Characteristics Diagram

### 9.5 Device Function

#### 9.5.1 Disable

When the DIS pin is set high, both outputs can be shut down at the same time. The device operates normally when the DIS pin is grounded or left open. The response time of the disable function is within 20ns. The disable function is activated or deactivated according to the input only when the VCC is kept above the undervoltage turn-on threshold. If the DIS pin is not used, it is recommended to connect it to the ground. If connecting DIS pin to a microcontroller with distance, it is recommended to bypass the DIS pin with a low ESR/ESL capacitor of approximately 1nF for better noise immunity.

#### 9.5.2 Pulling DT Pin Up to VCC

The two channels are independent, with output exactly matching input, and no dead time is inserted, allowing the output signals to be both high.

#### 9.5.3 Dead Time Setting

DT pin sets the dead time. It is used to set the dead time between channel 1 and channel 2 to prevent them from shoot-through. The steady-state voltage of DT pin is 0.8V, and the current value of the pin is measured for corresponding dead time. The dead time is calculated as  $t_{DT} = 10 \times R_{DT}$ . The unit of  $t_{DT}$  is ns and the unit of  $R_{DT}$  is kΩ. To ensure that the pin signal is not interfered, it is recommended to place a 2.2nF capacitor near the IC between DT pin and GND, and it is not recommended to leave DT pin open.



Figure 34. Dead Time Setting

The falling edge of one input signal activates the the programmed dead time for the other signal. The dead time of the output signal is selected by IC, either the dead time set by IC itself or for the dead time of input signal itself, and the IC output chooses the longer one out of the two. If both input signals are high at the same time, both output signals are immediately set to low. This feature is intended to prevent shoot-through and does not affect the normal operation of the dead time settings. The following figure illustrates and demonstrates the various dead time logical operations.

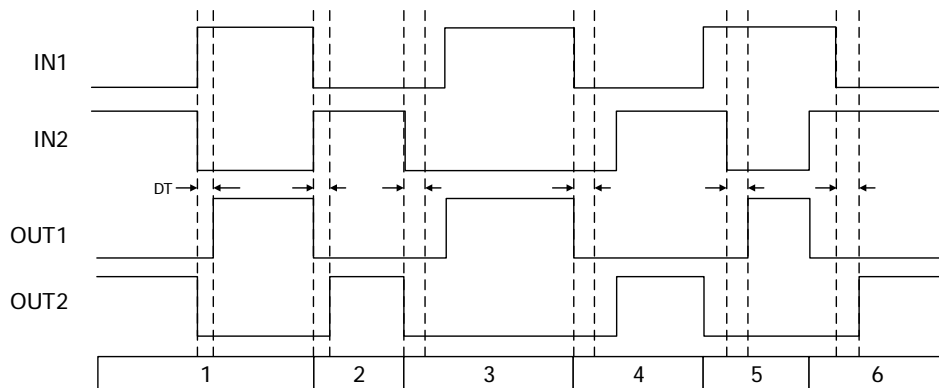


Figure 35. BTD21520M Input and Output Logic Relationship With Input Signals

**State 1:** IN2 goes low, IN1 goes high. IN2 sets OUT2 low immediately and assigns the programmed dead time to OUT1. OUT1 is allowed to go high after the programmed dead time.

**State 2:** IN2 goes high, IN1 goes low. Now IN1 sets OUT1 low immediately and assigns the programmed dead time to OUT2. OUT2 is allowed to go high after the programmed dead time.

**State 3:** IN2 goes low, IN1 is still low. IN2 sets OUT2 low immediately and assigns the programmed dead time for OUT1. In this case, the input signal's own dead time is longer than the programmed dead time. Thus, when IN1 goes high, it immediately sets OUT1 high.

**State 4:** IN1 goes low, IN2 is still low. IN1 sets OUT1 low immediately and assigns the programmed dead time to OUT2. IN2's own dead time is longer than the programmed dead time. Thus, when IN2 goes high, it immediately sets OUT2 high.

**State 5:** IN1 goes high, while IN2 and OUT2 are still high. To avoid overshoot, IN1 immediately pulls OUT1 low and keeps OUT1 low. After some time IN2 goes low and assigns the programmed dead time to OUT1. OUT2 is already low. After the programmed dead time, OUT1 is allowed to go high.

**State 6:** IN2 goes high, while IN1 and OUT1 are still high. To avoid overshoot, IN2 immediately pulls OUT1 low and keeps OUT2 low. After some time IN1 goes low and assigns the programmed dead time to OUT2. OUT1 is already low. After the programmed dead time, OUT2 is allowed to go high.

### 9.5.4 BTD21520E Dead Time

A dead time elapses before OUT1 or OUT2 goes high, so as to prevent the high and low side MOSFET shoot-through.

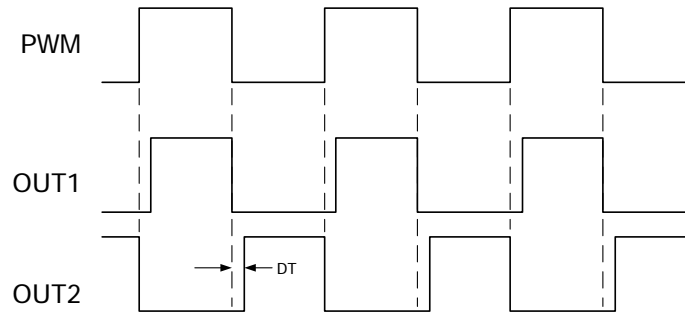


Figure 36. Logic relationship between input and output signals of BTD21520E

## 9.6 Protection Function

### 9.6.1 UVLO

There is an internal undervoltage lock-out (UVLO) on the power circuit function area between VDDx and VEE pins of two out-puts. When the voltage of VDDx is below the undervoltage recovery threshold before starting, or below the undervoltage protection threshold after starting, the output will remain low regardless of the input state. When the output of the driver is in powered-off or undervoltage state, its output is clamped to the low level by the active clamping circuit, as shown in the figure below. At this time, the PMOS of the high side is blocked and high impedance, and the NMOS gate of the low side is connected to the output of the driver by the resistor  $R_{CLAMP}$ . In the absence of bias voltage, the output is effectively clamped to the threshold voltage of the low-side NMOS device, typically around 1.5V (see Figure 35).

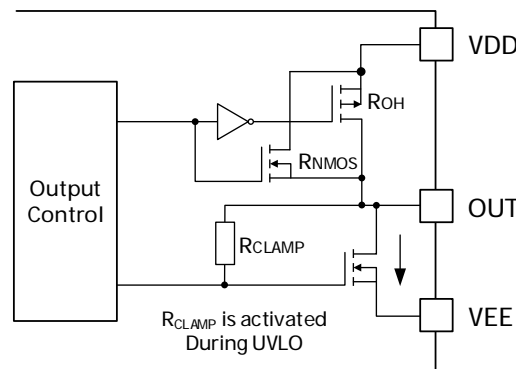


Figure 37. Simplified Representation of Active Pulldown Feature

The VDDx undervoltage protection has a  $V_{VDD\_HYS}$  feature that prevents vibration in the presence of noise from the power supply to ground. This also allows the device to accept a small decrease in bias voltage when the device starts to turn on/off and the operating current consumption increases abruptly. Like the VDDx, there is also an undervoltage lock-out (UVLO) integrated on the primary side of the VCC. When the bias voltage is applied to the VCC terminal and the voltage is lower than the undervoltage turn-on threshold, the device will not be activated. After the activation of the device, if the VCC voltage continuously decreases to the undervoltage turn-off threshold, the signal will stop transmission. Like the undervoltage lockout of VDD, the undervoltage lockout of VCC also has hysteresis feature.

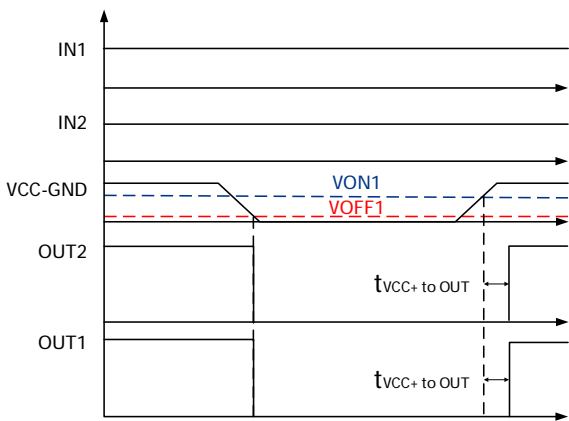


Figure 38. VCC Timing Diagram of Undervoltage Lockout

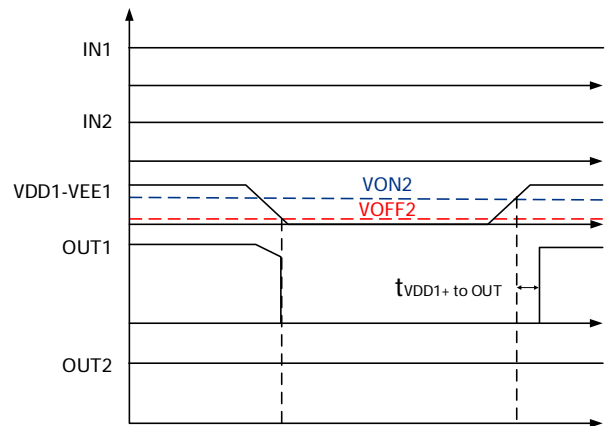


Figure 39. VDD1 Timing Diagram of Undervoltage Lockout

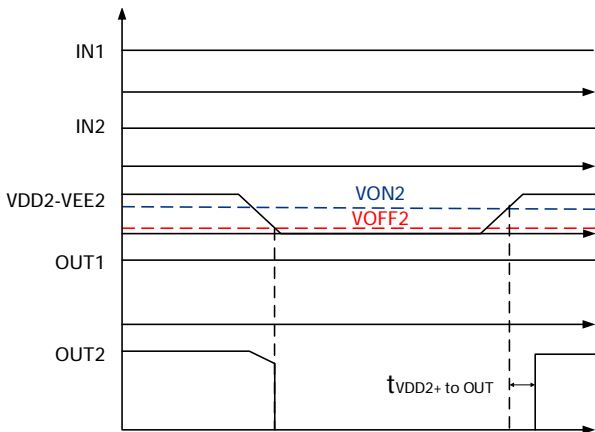


Figure 40. VDD2 Timing Diagram of Undervoltage Lockout

### 9.7 ESD Structure

The figure below shows the ESD-protected diode configuration of the input and output pins.

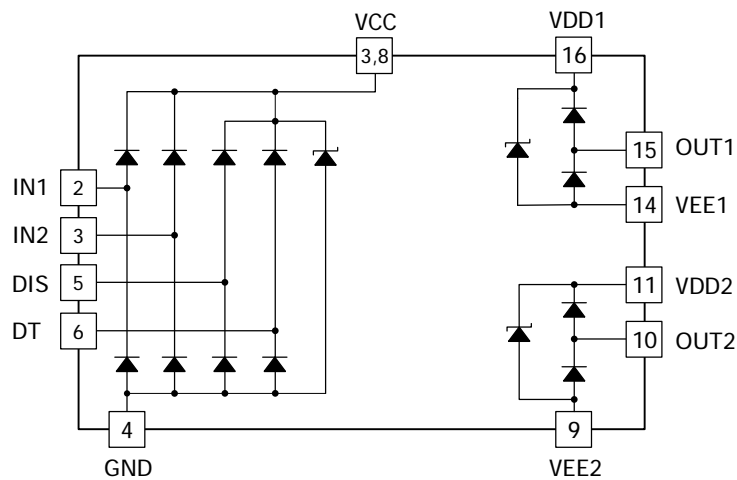


Figure 41. ESD Structure Diagram

## 10.Applications

The following sections introduce the basic typical application of the driver ICs, which is for reference only. In practical application, users need to verify and test its applicability according to their own design requirements to confirm the system function.

### 10.1 Typical Applications

It is recommended that customers add a RC filter with a small time constant at the input port to filter out high-frequency interference without adding a large delay. It is recommended that the resistance value should be between 0 and 100Ω and the capacitance should be less than 1000pF. When setting this parameter, the influence between high frequency interference and delay needs to be taken into account.

To ensure the supply stability, It is recommended to add an appropriate capacitor between the power supply and ground. It is recommended that the primary side supply VCC-GND be connected in parallel with 1uF+ 0.1uF capacitor  $C_{VCC}$ , and the secondary side supply VDDx-VEEx be connected with 10μF+ 0.22μF capacitors  $C_{VDD1}$  and  $C_{VDD2}$ .

The bootstrap capacitor is charged by VDD through an external bootstrap diode every cycle when the low side transistor turns on. Charging the capacitor involves high-peak currents, and therefore transient power dissipation in the bootstrap diode may be significant. Conduction loss also depends on the diode's forward voltage drop. Both the diode conduction losses and reverse recovery losses contribute to the total losses in the gate driver circuit.

The recommended value for  $R_{BOOT}$  is between 1 Ω and 20 Ω depending on the diode used.

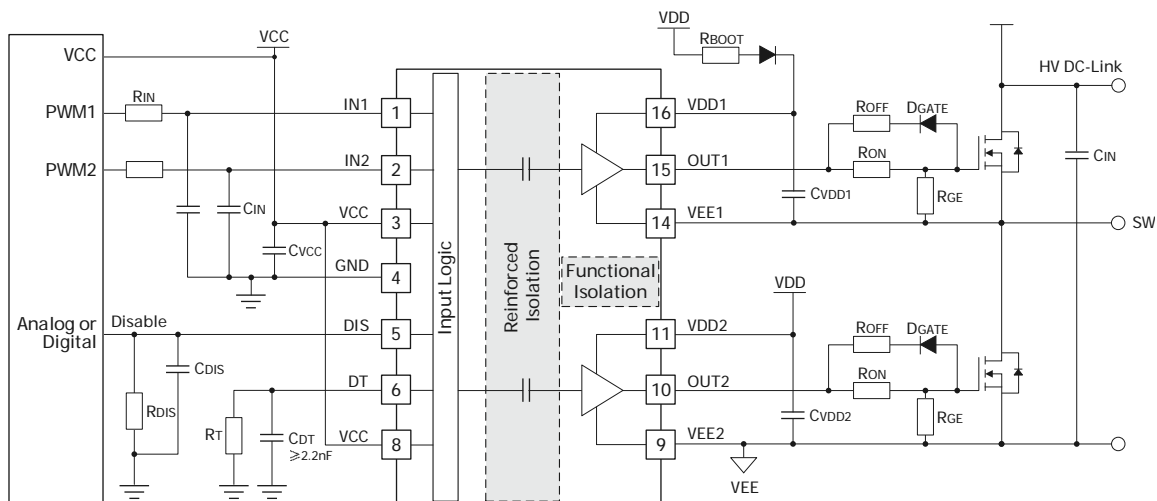


Figure 42. BTD21520M Application Diagram

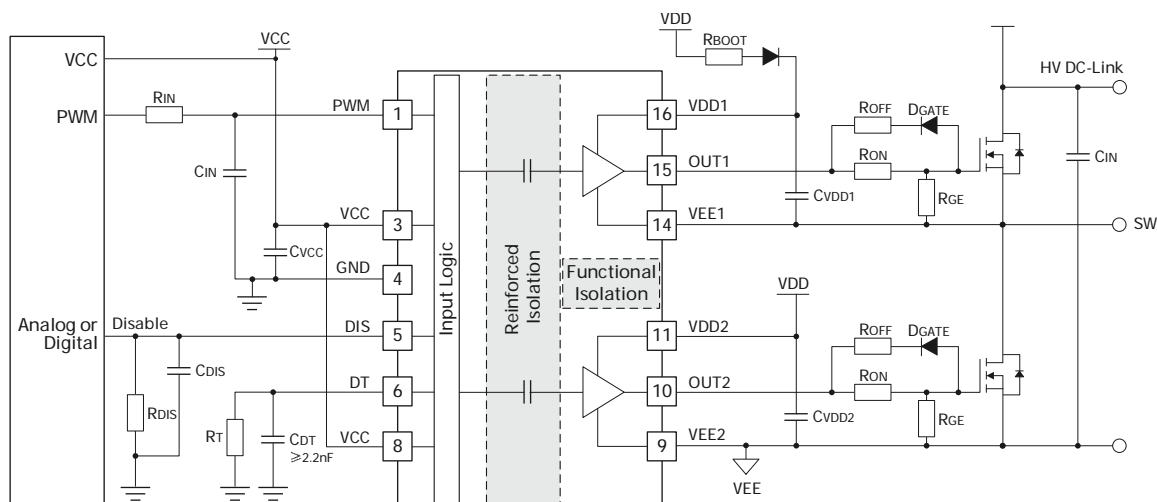


Figure 43. BTD21520E Application Diagram

## 10.2 Recommended Designs

### 10.2.1 Recommended Design of Secondary Side Supply

In order to avoid partial turn-on of the gate of the power device due to interference, it is recommended that customers add a negative supply when designing the driving output. It is recommended to use the following two methods to generate the negative supply: Use a regulator to generate stable negative voltage, or use both positive and negative supplies.

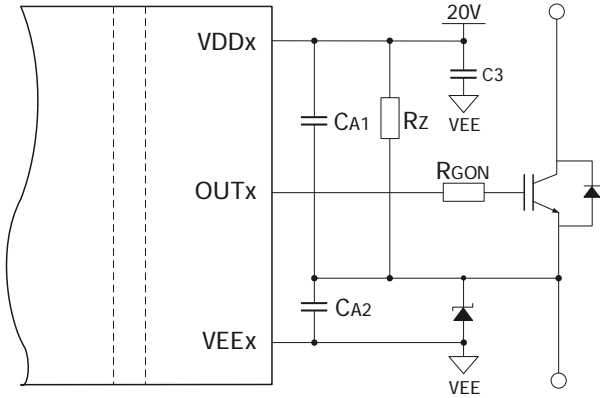


Figure 44. Voltage Regulator Design

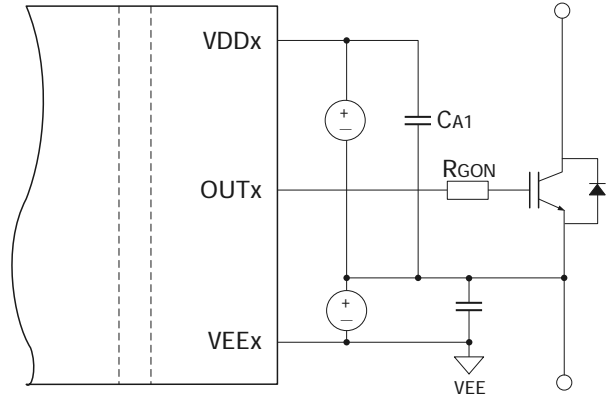
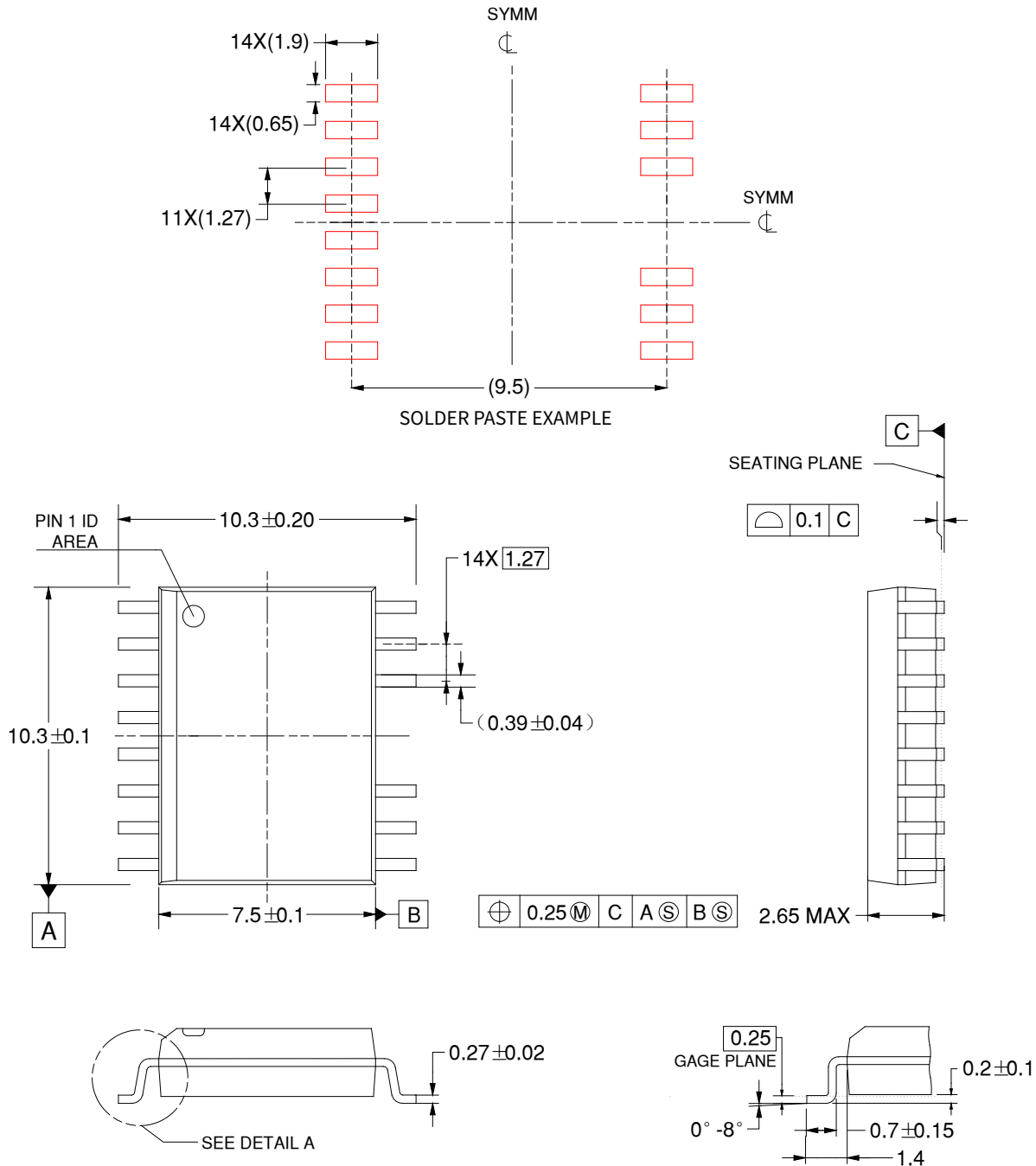


Figure 45. Dual-Supply Design

## 11. Packaging and Packing Information

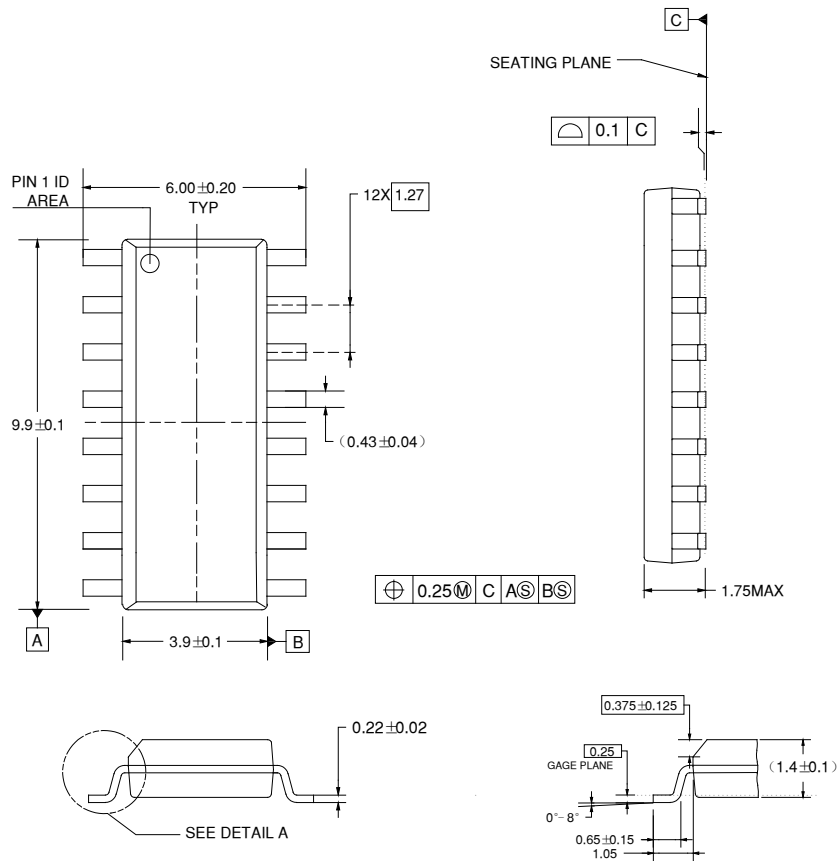
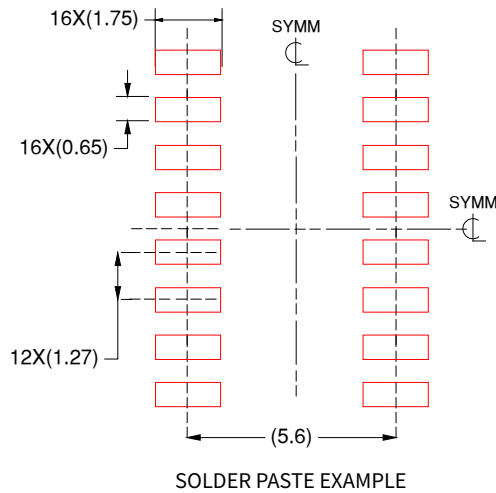
### 11.1 Package Identifier

#### 11.1.1 SOW-14 Package Identifier



Note: 1)Legend unit: mm.

11.1.2 SOP-16 Package Identifier



Note: 1) Legend unit: mm.

**Electrostatic Discharge Caution**



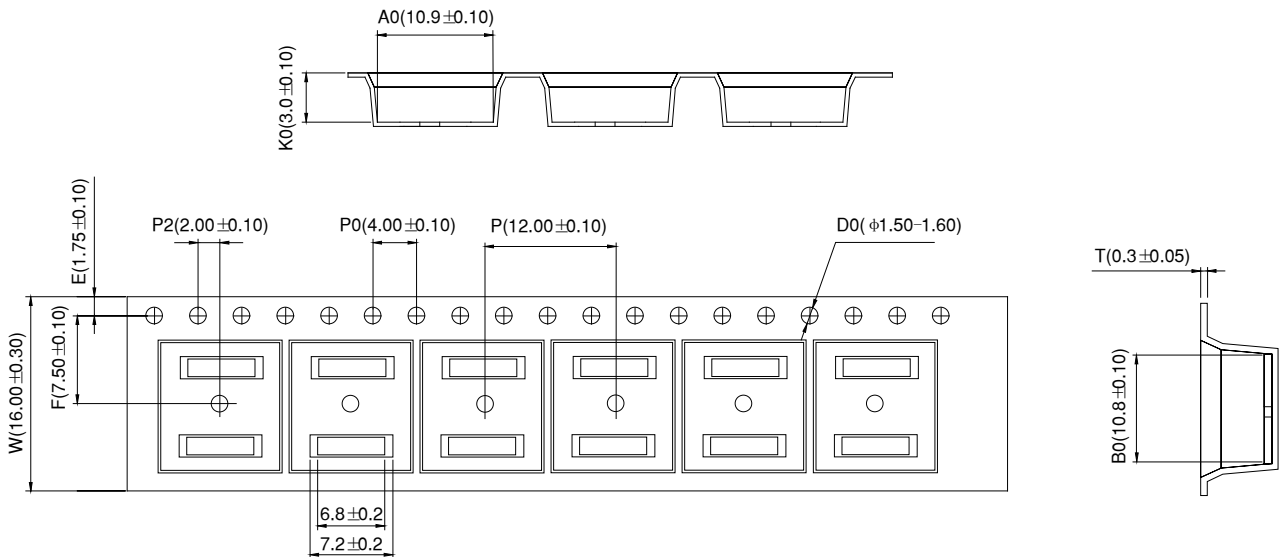
This integrated circuit can be damaged by ESD. It is recommended that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



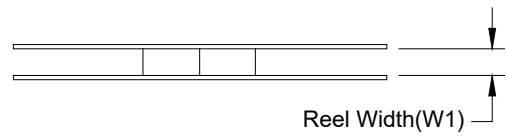
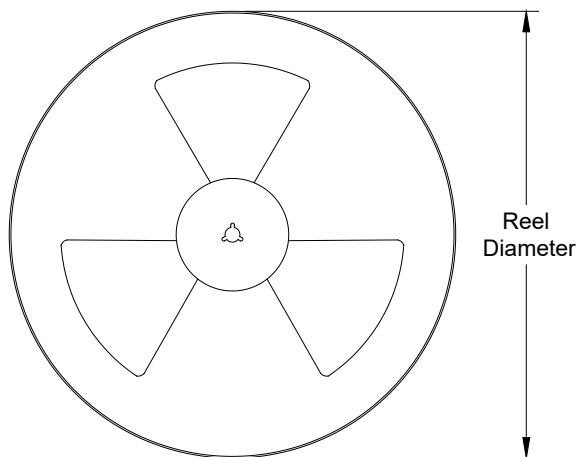
**11.2 Packing Information**

**11.2.1 SOW-14 Packing Information**



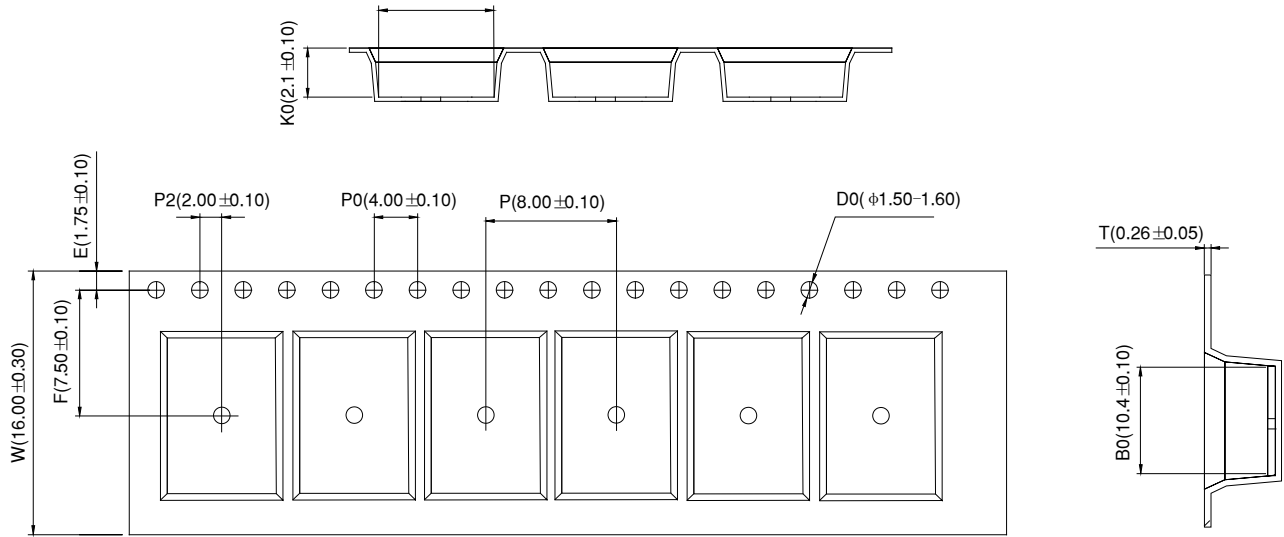
Note: 1) Legend unit: mm.

**REEL DIMENSIONS**



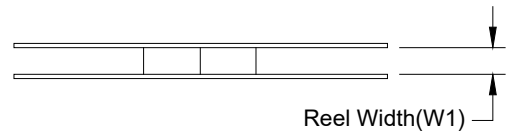
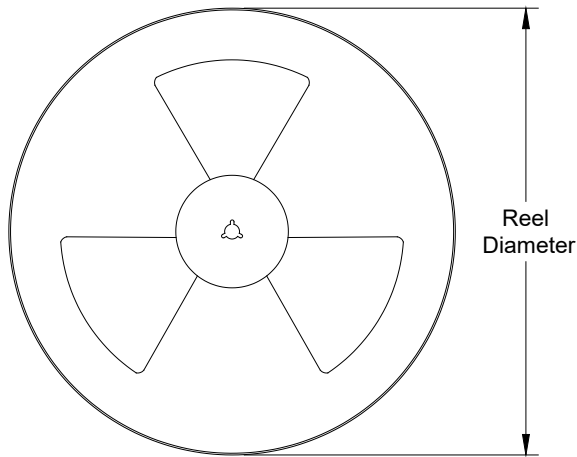
| ITEM           | FOOTPRINT |
|----------------|-----------|
| Reel Diameter  | 13 inches |
| Reel Width(W1) | 12.4mm    |

**11.2.2 SOP-16 Packing Information**



Note: 1) Legend unit: mm.

**REEL DIMENSIONS**



| ITEM           | FOOTPRINT |
|----------------|-----------|
| Reel Diameter  | 13 inches |
| Reel Width(W1) | 16mm      |

## 12.Version Description

| REVISION | NOTES  | DATE        |
|----------|--|-------------|
| Rev.0.0  | Released datasheet                                       | 12-Jan-2023 |
| Rev.0.1  | Parameters extended and SOP-16 package information added | 15-Dec-2023 |
| Rev.0.2  | Safety certification added                               | 28-Mar-2024 |
| Rev.0.3  | The content updated                                      | 11-Sep-2024 |

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